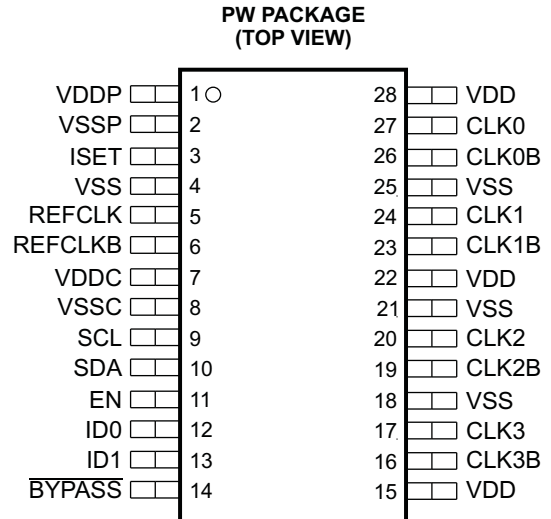


## Rambus™ XDR™ CLOCK GENERATOR

### FEATURES

- **High-Speed Clock Support: 300-MHz–667-MHz Clock Source for XDR Memory Subsystems and Redwood Logic Interface**
- **Quad (Open-Drain) Differential Output Drivers**
- **Spread-Spectrum Compatible Clock Input Can Be Distributed to Minimize EMI**
- **Differential or Single-Ended Reference Clock Input of 100 MHz or 133 MHz**
- **Serial Interface Features: Programmable Frequency Multiplier, Select Any One to Four Outputs and Mode of Operation**
- **Supports Frequency Multiplication Factors of:  $\times 3$ ,  $\times 4$ ,  $\times 5$ ,  $\times 6$ ,  $\times 8$ ,  $\times 9/2$ ,  $\times 15/2$ ,  $\times 15/4$**
- **All PLL Loop Filter Components Are Integrated**
- **Low |Cycle-to-Cycle| of 1–6 Cycle Jitter:**
  - 40 ps: 300–635 MHz
  - 30 ps: 636–667 MHz
- **PLLs Are Powered Down if No Valid REF Clock (<10 MHz) Is Detected or VDD Is Below 1.6 V**
- **Operates From Single 2.5-V Supply ( $\pm 0.125$  V)**
- **Packaged in TSSOP-28**
- **Commercial Temperature Range 0°C to 70°C**



P0043-01

### APPLICATIONS

- **XDR Memory Subsystem and Redwood Logic Interface**

### DESCRIPTION

The CDCD5704 clock generator provides the necessary clock signals to support an XDR memory subsystem and Redwood logic interface using a reference clock input with or without spread-spectrum modulation. Contained in a 28-pin TSSOP package that includes four differential clock outputs, the CDCD5704 provides an off-the-shelf solution for a broad range of high-performance interface applications.

The block diagram shows the major components of the CDCD5704, which include a phase-locked loop, a bypass multiplexer, and four differential output buffers (CLK0 to CLK3). All four outputs can be disabled by a logical low at the input of the EN pin. An output is enabled when EN is high and a value of 1 is in its serial interface register (RegA–RegD).

The PLL receives a reference clock input signal, REFCLK, and outputs a clock signal at a frequency equal to the input frequency times the multiplication factor. The PLL output clock signal is fed to the differential output buffers to drive the enabled clocks. Disabled outputs are set to high impedance.



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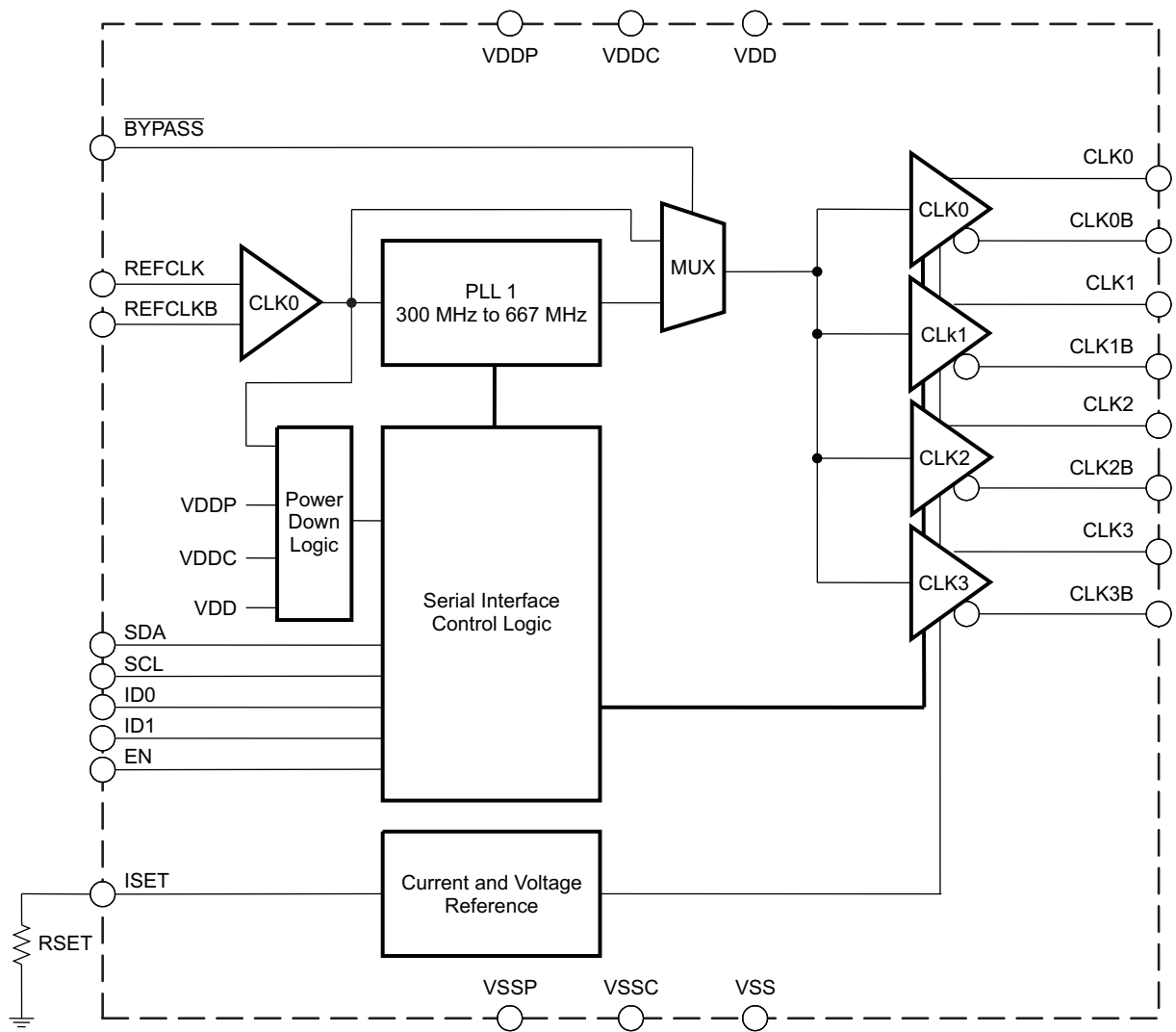
The bypass mode routes the input clock REFCLK to the differential output buffers, bypassing the PLL.

To ensure that the CDCD5704 clock generator always performs correctly, the device switches off the PLL and the outputs are in the high-impedance state, once the clock input is below 10 MHz. If the supply voltage VDD is less than  $V_{PUC}$ , all logic gates are reset, the PLL is powered down, and the outputs are in the high-impedance state. Therefore, the device only starts its operation if these minimum requirements are met.

Because the CDCD5704 is based on PLL circuitry, it requires a stabilization time to achieve phase-lock of the PLL. With use of an external reference clock, this signal must be fixed-frequency and fixed-phase prior to the start of stabilization time.

The device operates from a single 2.5-V supply voltage. The CDCD5704 device is characterized for operation from 0°C to 70°C.

**FUNCTIONAL BLOCK DIAGRAM**



B0137-01

**Table 1. TERMINAL FUNCTIONS**

| TERMINAL |               | TYPE   | DESCRIPTION  |
|----------|---------------|--------|--|
| NAME     | NO.           |        |  |
| BYPASS   | 14            | Input  | If 0, the PLL is bypassed and the PLL is switched off. |
| CLK0     | 27            | Output | Output for Clock0                                      |
| CLK0B    | 26            | Output | Complementary output for Clock0                        |
| CLK1     | 24            | Output | Output for Clock1                                      |
| CLK1B    | 23            | Output | Complementary output for Clock1                        |
| CLK2     | 20            | Output | Output for Clock2                                      |
| CLK2B    | 19            | Output | Complementary output for Clock2                        |
| CLK3     | 17            | Output | Output for Clock3                                      |
| CLK3B    | 16            | Output | Complementary output for Clock3                        |
| EN       | 11            | Input  | Output enable; if 0, all outputs are disabled.         |
| ID0      | 12            | Input  | Device ID, bit 0                                       |
| ID1      | 13            | Input  | Device ID, bit 1                                       |
| ISET     | 3             | Output | Set clock driver current with external resistor        |
| REFCLK   | 5             | Input  | Reference clock input                                  |
| REFCLKB  | 6             | Input  | Complementary reference clock input                    |
| SCL      | 9             | Input  | Serial interface clock, 3.3-V compatible               |
| SDA      | 10            | Input  | Serial interface data, 3.3-V compatible                |
| VDD      | 15, 22, 28    | Power  | 2.5-V power supply for outputs                         |
| VDDC     | 7             | Power  | 2.5-V power supply for core                            |
| VDDP     | 1             | Power  | 2.5-V power supply for PLL                             |
| VSS      | 4, 18, 21, 25 | Ground | Ground   |
| VSSC     | 8             | Ground | Ground for core  |
| VSSP     | 2             | Ground | Ground for PLL   |

## SERIAL INTERFACE

The following section describes the serial interface programming. In general, the serial interface slave supports byte-write/-read and word-write/-read protocol as defined in the SMBus or I<sup>2</sup>C specification.

### Serial Interface Operation Requirement

The internal timing of the serial interface logic block in the CDCD5704 requires a timing reference derived from the input clock (REFCLK). A reference clock must be present at the REFCLK pin for the serial interface to be operational.

### Serial Interface Device Address

| A6 | A5 | A4 | A3 | A2 | A1  | A0  | W/R |
|----|----|----|----|----|-----|-----|-----|
| 1  | 1  | 0  | 1  | 1  | ID1 | ID0 | 0/1 |

The device-ID is determined by the external pins ID0 and ID1. They are part of the device 8-bit address. Therefore, four different devices (00, 01, 10, and 11) can be addressed via the same serial interface. The least significant bit of the address designates a write or read operation.

R/W Bit:

- 0 = write to CDCD5704 device
- 1 = read from CDCD5704 device

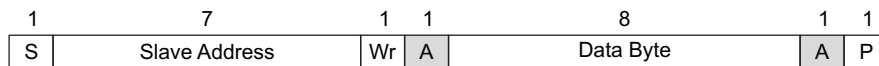
### Command Code Definition

| Bit     | Description  |
|---------|--|
| C7      | 1 = byte-write/-read or word-write/-read operation             |
| (C6:C0) | Byte offset for byte-write/-read or word-write/-read operation |

| Command Code for Byte-Write/-Read Operation | Hex Code | C7 | C6 | C5 | C4 | C3 | C2 | C1 | C0 |
|---|----------|----|----|----|----|----|----|----|----|
| Byte 0                                      | 80h      | 1  | 0  | 0  | 0  | 0  | 0  | 0  | 0  |
| Byte 1                                      | 81h      | 1  | 0  | 0  | 0  | 0  | 0  | 0  | 1  |
| Byte 2                                      | 82h      | 1  | 0  | 0  | 0  | 0  | 0  | 1  | 0  |

| Command Code for Word-Write/-Read Operation | Hex Code | C7 | C6 | C5 | C4 | C3 | C2 | C1 | C0 |
|---|----------|----|----|----|----|----|----|----|----|
| Word 0: Byte 0 and byte 1                   | 80h      | 1  | 0  | 0  | 0  | 0  | 0  | 0  | 0  |
| Word 1: Byte 1 and byte 2                   | 81h      | 1  | 0  | 0  | 0  | 0  | 0  | 0  | 1  |

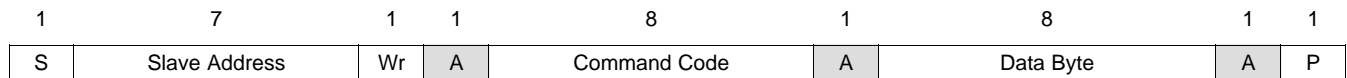
### Serial Interface Generic Programming Sequence



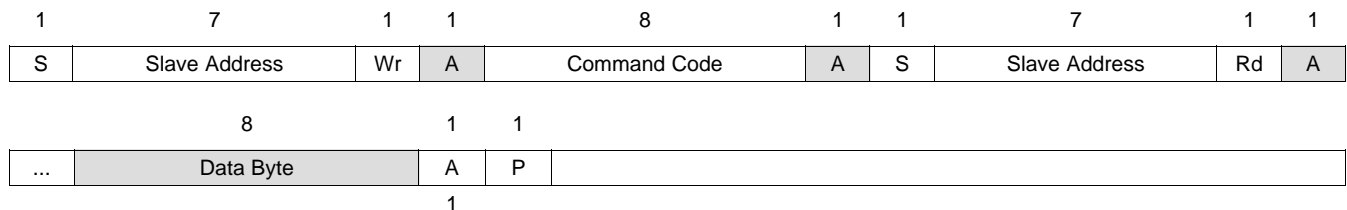
- S Start Condition
- Sr Repeated Start Condition
- Rd Read (Bit Value = 1)
- Wr Write (Bit Value = 0)
- A Acknowledge (ACK = 0 and NACK = 1)
- P Stop Condition
- PE Packet Error
- Master-to-Slave Transmission
- Slave-to-Master Transmission

M0053-01

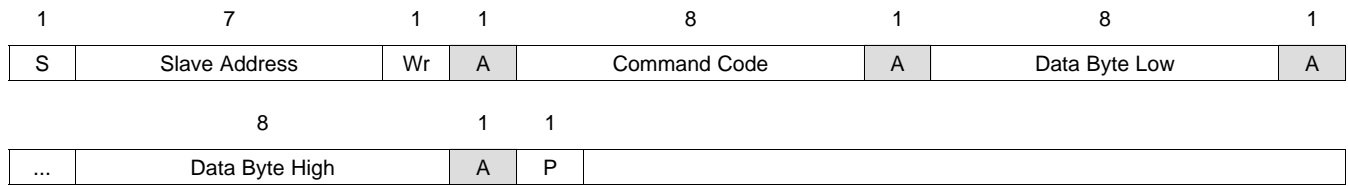
### Byte-Write Programming Sequence



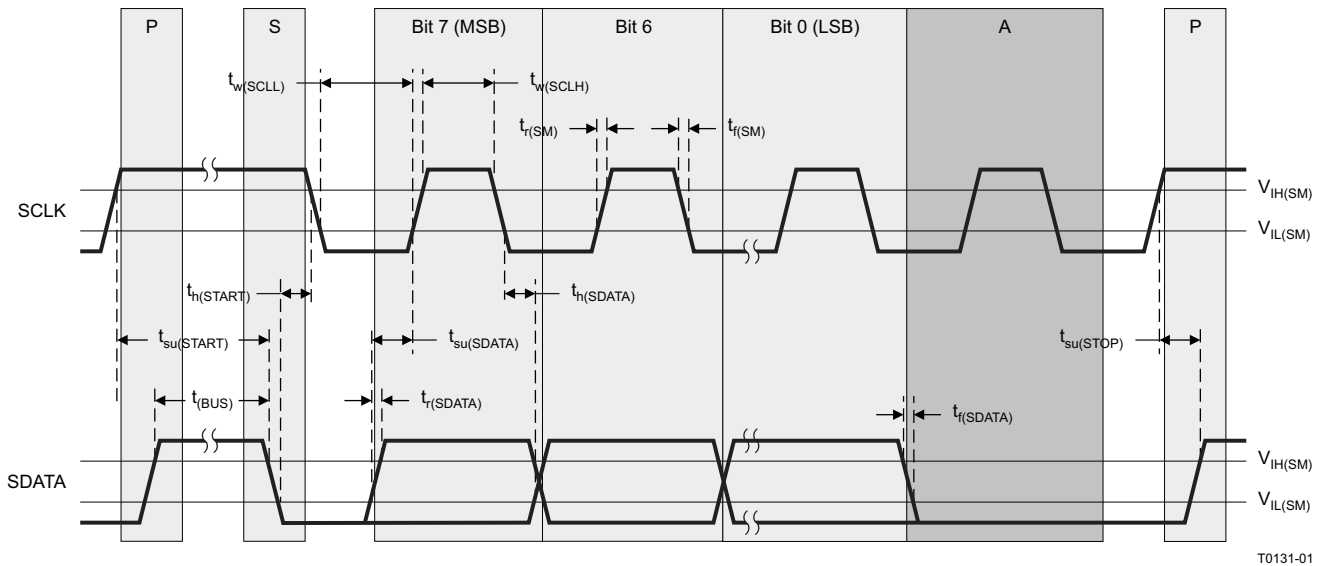
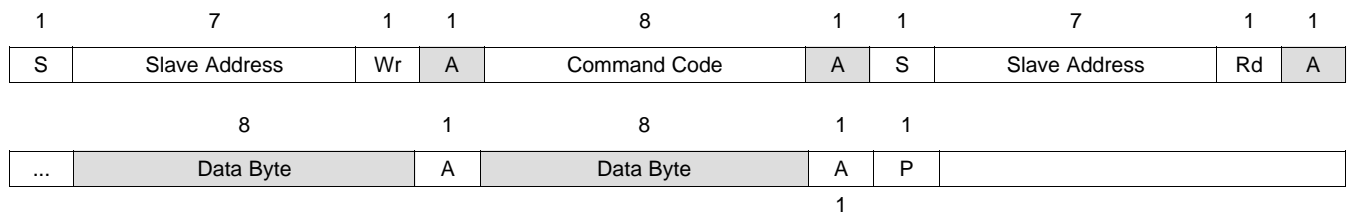
### Byte-Read Programming Sequence



**Word-Write Programming Sequence**



**Word-Read Programming Sequence**



T0131-01

**Figure 1. Timing Diagram, Serial Control Interface**

## Serial Interface Configuration Command Bitmap

### Byte 0

| Bit | Bit Name | Description/Function         | Type | Power-Up Condition |
|-----|----------|------------------------------|------|--------------------|
| 7   | RES      | Reserved                     | R/W  | 0                  |
| 6   | MULT2    | Multiplication factor, bit 2 | R/W  | 0                  |
| 5   | MULT1    | Multiplication factor, bit 1 | R/W  | 0                  |
| 4   | MULT0    | Multiplication factor, bit 0 | R/W  | 1                  |
| 3   | RegA     | Enable CLK0                  | R/W  | 1                  |
| 2   | RegB     | Enable CLK1                  | R/W  | 1                  |
| 1   | RegC     | Enable CLK2                  | R/W  | 1                  |
| 0   | RegD     | Enable CLK3                  | R/W  | 1                  |

### Byte 1

| Bit | Bit Name | Description/Function                            | Type | Power-Up Condition |
|-----|----------|---|------|--------------------|
| 7   | RES      | Reserved  | R/W  | 0                  |
| 6   | RES      | Reserved  | R/W  | 0                  |
| 5   | RES      | Reserved  | R/W  | 0                  |
| 4   | RES      | Reserved  | R/W  | 0                  |
| 3   | RES      | Reserved for vendor option                      | R/W  | 0                  |
| 2   | RES      | Reserved for vendor option                      | R/W  | 0                  |
| 1   | RES      | Reserved for vendor option                      | R/W  | 0                  |
| 0   | RegTest  | Vendor test register. If high, then Vendor Test | R/W  | 0                  |

### Byte 2

| Bit | Bit Name | Description/Function   | Type | Power-Up Condition |
|-----|----------|------------------------|------|--------------------|
| 7   | REV0     | Device revision, bit 4 | R    | 0                  |
| 6   | REV0     | Device revision, bit 3 | R    | 0                  |
| 5   | REV0     | Device revision, bit 2 | R    | 0                  |
| 4   | REV0     | Device revision, bit 1 | R    | 0                  |
| 3   | REV0     | Device revision, bit 0 | R    | 0                  |
| 2   | VID2     | Vendor ID bit 2        | R    | 0                  |
| 1   | VID1     | Vendor ID bit 1        | R    | 1                  |
| 0   | VID0     | Vendor ID bit 0        | R    | 1                  |

## FUNCTIONAL DESCRIPTION OF THE LOGIC

### PLL Multiplication Factor Selection

| Mult2            | Mult1            | Mult0            | Multiplication Factor | Output Frequency (MHz) |                    |
|------------------|------------------|------------------|-----------------------|------------------------|--------------------|
|                  |                  |                  |                       | REFCLK = 100 MHz       | REFCLK = 133 MHz   |
| 0                | 0                | 0                | 3                     | 300                    | 400                |
| 0 <sup>(1)</sup> | 0 <sup>(1)</sup> | 1 <sup>(1)</sup> | 4 <sup>(1)</sup>      | 400                    | 533                |
| 0                | 1                | 0                | 5                     | 500                    | 667                |
| 0                | 1                | 1                | 6                     | 600                    | 800 <sup>(2)</sup> |
| 1                | 0                | 0                | 8                     | 800 <sup>(2)</sup>     | – <sup>(2)</sup>   |
| 1                | 0                | 1                | 9/2                   | 450                    | 600                |
| 1                | 1                | 0                | 15/2                  | 750 <sup>(2)</sup>     | – <sup>(2)</sup>   |
| 1                | 1                | 1                | 15/4                  | 375                    | 500                |

(1) Default settings after power up

(2) Output at this frequency does not conform to all the ac device characteristics in the *Device Characteristics* table, or output frequency is not supported.

### Modes of Operation

| EN | BYPASS | Reg-Test         | RegA             | RegB             | RegC             | RegD             | CLK0                     | CLK1    | CLK2    | CLK3    |
|----|--------|------------------|------------------|------------------|------------------|------------------|--------------------------|---------|---------|---------|
| L  | X      | X                | X                | X                | X                | X                | HI-Z                     | HI-Z    | HI-Z    | HI-Z    |
| H  | X      | 1                | X                | X                | X                | X                | RESERVED FOR VENDOR TEST |         |         |         |
| H  | L      | 0                | X                | X                | X                | X                | REFCLK                   | REFCLK  | REFCLK  | REFCLK  |
| H  | H      | 0                | 0                | 0                | 0                | 0                | HI-Z                     | HI-Z    | HI-Z    | HI-Z    |
| H  | H      | 0                | 1                | 0                | 0                | 0                | PLL CLK                  | HI-Z    | HI-Z    | HI-Z    |
| H  | H      | 0                | 0                | 1                | 0                | 0                | HI-Z                     | PLL CLK | HI-Z    | HI-Z    |
| H  | H      | 0                | 1                | 1                | 0                | 0                | PLL CLK                  | PLL CLK | HI-Z    | HI-Z    |
| H  | H      | 0                | 0                | 0                | 1                | 0                | HI-Z                     | HI-Z    | PLL CLK | HI-Z    |
| H  | H      | 0                | 1                | 0                | 1                | 0                | PLL CLK                  | HI-Z    | PLL CLK | HI-Z    |
| H  | H      | 0                | 0                | 1                | 1                | 0                | HI-Z                     | PLL CLK | PLL CLK | HI-Z    |
| H  | H      | 0                | 1                | 1                | 1                | 0                | PLL CLK                  | PLL CLK | PLL CLK | HI-Z    |
| H  | H      | 0                | 0                | 0                | 0                | 1                | HI-Z                     | HI-Z    | HI-Z    | PLL CLK |
| H  | H      | 0                | 1                | 0                | 0                | 1                | PLL CLK                  | HI-Z    | HI-Z    | PLL CLK |
| H  | H      | 0                | 0                | 1                | 0                | 1                | HI-Z                     | PLL CLK | HI-Z    | PLL CLK |
| H  | H      | 0                | 1                | 1                | 0                | 1                | PLL CLK                  | PLL CLK | HI-Z    | PLL CLK |
| H  | H      | 0                | 0                | 0                | 1                | 1                | HI-Z                     | HI-Z    | PLL CLK | PLL CLK |
| H  | H      | 0                | 1                | 0                | 1                | 1                | PLL CLK                  | HI-Z    | PLL CLK | PLL CLK |
| H  | H      | 0                | 0                | 1                | 1                | 1                | HI-Z                     | PLL CLK | PLL CLK | PLL CLK |
| H  | H      | 0 <sup>(1)</sup> | 1 <sup>(1)</sup> | 1 <sup>(1)</sup> | 1 <sup>(1)</sup> | 1 <sup>(1)</sup> | PLL CLK                  | PLL CLK | PLL CLK | PLL CLK |

(1) Default settings after power up

### ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|                  |  | VALUE                         | UNIT                           |
|------------------|--|-------------------------------|--------------------------------|
| V <sub>DD</sub>  | Supply voltage range   | -0.3 to 2.8                   | V                              |
| V <sub>I</sub>   | Input voltage range <sup>(2)</sup>   | For SCL and SDA               | -0.3 to 3.6                    |
|                  |  | For all other inputs          | -0.3 to V <sub>DD</sub> + 0.25 |
| V <sub>O</sub>   | Output voltage range <sup>(2)</sup>  | -0.5 to V <sub>DD</sub> + 0.5 | V                              |
| I <sub>IK</sub>  | Input clamp current, (V <sub>I</sub> < 0, V <sub>I</sub> > V <sub>DD</sub> ) | ±20                           | mA                             |
| I <sub>O</sub>   | Continuous output current  | ±50                           | mA                             |
| R <sub>θJA</sub> | Thermal resistance, junction-to-ambient <sup>(3)</sup>                       | No airflow                    | 94.4                           |
|                  |  | Airflow 150 ft/min            | 82.8                           |
|                  |  | Airflow 250 ft/min            | 79.1                           |
|                  |  | Airflow 500 ft/min            | 74                             |
| R <sub>θJC</sub> | Thermal resistance, junction-to-case <sup>(3)</sup>                          | No airflow                    | 31.8                           |
| R <sub>θJB</sub> | Thermal resistance, junction-to-board <sup>(3)</sup>                         | No airflow                    | 68.9                           |
| T <sub>J</sub>   | Maximum junction temperature   | 125                           | °C                             |
| T <sub>stg</sub> | Storage temperature range  | -65 to 150                    | °C                             |

- (1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The input and output negative voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- (3) The package thermal impedance is calculated in accordance with JESD 51 and JEDEC2S1P (high-k board).

### RECOMMENDED DC OPERATING CONDITIONS

|                      |   | MIN                      | NOM | MAX                      | UNIT |
|----------------------|---|--------------------------|-----|--------------------------|------|
| V <sub>DDP</sub>     | Supply voltage for PLL  | 2.375                    | 2.5 | 2.625                    | V    |
| V <sub>DDC</sub>     | Supply voltage for core   | 2.375                    | 2.5 | 2.625                    | V    |
| V <sub>DD</sub>      | Supply voltage for clock buffers                                | 2.375                    | 2.5 | 2.625                    | V    |
| T <sub>A</sub>       | Operating free-air temperature                                  | 0                        |     | 70                       | °C   |
| V <sub>IL,CLK</sub>  | Low-level input voltage, REFCLK/REFCLKB                         | -0.15                    |     | 0.15                     | V    |
| V <sub>IX,CLK</sub>  | Crossing-point voltage, input voltage threshold, REFCLK/REFCLKB | 0.2                      |     | 0.55                     | V    |
| V <sub>IH,CLKD</sub> | High-level input voltage, REFCLK/REFCLKB                        | 0.6                      |     | 0.95                     | V    |
| ΔV <sub>IX,CLK</sub> | Difference in crossing-point voltage                            |                          |     | 0.15                     | V    |
| V <sub>IL SE</sub>   | Low-level, single-ended input voltage, REFCLK                   | -0.15                    |     | V <sub>th SE</sub> - 0.3 | V    |
| V <sub>th SE</sub>   | Single-ended input-voltage threshold, REFCLK <sup>(1)</sup>     | 0.35                     |     | 0.5 V <sub>DD</sub>      | V    |
| V <sub>IH SE</sub>   | High-level, single-ended input voltage, REFCLK                  | V <sub>th SE</sub> + 0.3 |     | 2.625                    | V    |
| V <sub>IL L</sub>    | Low-level input voltage, ID0, ID1, EN, BYPASS                   | -0.15                    |     | 0.8                      | V    |
| V <sub>IH L</sub>    | High-level input voltage, ID0, ID1, EN, BYPASS                  | 1.4                      |     | 2.625                    | V    |
| V <sub>IL SM</sub>   | Low-level input voltage, SCL, SDA <sup>(2)</sup>                | -0.15                    |     | 0.8                      | V    |
| V <sub>IH SM</sub>   | High-level input voltage, SCL, SDA <sup>(2)</sup>               | 1.4                      |     | 3.465                    | V    |

- (1) When using a single-ended clock input, V<sub>th</sub> is supplied to the REFCLKB pin. Duty cycle of single-ended REFCLK input is measured at V<sub>th</sub>.
- (2) This range of SCL and SDA input high voltage allows the CD5704 to co-exist with 3.3 V, 2.5 V, and 1.8 V devices on the same serial-interface bus system.



## RECOMMENDED AC OPERATING CONDITIONS

|   |  | MIN | NOM | MAX  | UNIT          |
|---|--|-----|-----|------|---------------|
| $t_{\text{CYCLE,IN}}$                         | REFCLK/REFCLKB input cycle time  | 7   |     | 11   | ns            |
| $t_{\text{Cyc,TEST}}$                         | REFCLK/REFCLKB input cycle time for $\overline{\text{BYPASS}}$                                       | 4   |     | 40   | ns            |
| $t_{\text{J,IN}}$                             | Input  cycle-to-cycle  jitter <sup>(1)</sup>   |     |     | 185  | ps            |
| $\text{DC}_{\text{IN}}$                       | Input duty cycle over 10,000 cycles <sup>(2)</sup>   | 40% |     | 60%  |               |
| $t_r/t_f$                                     | Rise and fall time for REFCLK signal from 20% to 80% of input voltage $V_{\text{IN}}$                | 175 |     | 700  | ps            |
| $t_{\text{Cr}}/t_{\text{cf}}$                 | Difference between rise time and fall time of REFCLK signal from 20% to 80%                          |     |     | 150  | ps            |
| $f_{\text{m,IN}}$                             | SSC frequency modulation repeat frequency <sup>(3)</sup>   | 30  |     | 33   | kHz           |
| $P_{\text{m tria}}$                           | Modulation index (= frequency deviation/center frequency) for triangle modulation <sup>(3)</sup>     |     |     | 0.6% |               |
| $P_{\text{m n tria}}$                         | Modulation index (= frequency deviation/center frequency) for non-triangle modulation <sup>(4)</sup> |     |     | 0.5% |               |
| $t_{\text{SR}}$                               | Input slew rate REFCLK/REFCLKB   | 1   |     | 4    | V/ns          |
| <b>SERIAL INTERFACE TIMING</b>                |  |     |     |      |               |
| $f_{\text{SCLK}}$                             | SCLK frequency <sup>(5)</sup>  | 0   |     | 100  | kHz           |
| $t_{\text{h(START)}}$                         | START hold time <sup>(5)</sup>   | 4   |     |      | $\mu\text{s}$ |
| $t_{\text{w(SCLL)}}$                          | SCLK low-pulse duration <sup>(5)</sup>   | 4.7 |     |      | $\mu\text{s}$ |
| $t_{\text{w(SCLH)}}$                          | SCLK high-pulse duration <sup>(5)</sup>  | 4   |     |      | $\mu\text{s}$ |
| $t_{\text{su(START)}}$                        | START setup time <sup>(5)</sup>  | 4.7 |     |      | $\mu\text{s}$ |
| $t_{\text{h(SDATA)}}$                         | SDATA hold time <sup>(5)</sup>   | 300 |     |      | ps            |
| $t_{\text{su(SDATA)}}$                        | SDATA setup time <sup>(5)</sup>  | 250 |     |      | ps            |
| $t_{\text{r(SDATA)}}$ /<br>$t_{\text{r(SM)}}$ | SDATA/SCLK input rise time <sup>(5)</sup>  |     |     | 1000 | ns            |
| $t_{\text{f(SDATA)}}$ /<br>$t_{\text{f(SM)}}$ | SDATA/SCLK input fall time <sup>(5)</sup>  |     |     | 300  | ns            |
| $t_{\text{su(STOP)}}$                         | STOP setup time <sup>(5)</sup>   | 4   |     |      | $\mu\text{s}$ |
| $t_{\text{(BUS)}}$                            | Bus free time  | 4.7 |     |      | $\mu\text{s}$ |

(1) RefCLK jitter is measured at  $(V_{\text{IH(nom)}} - V_{\text{IL(nom)}})/2$  and is the absolute value of the worst-case deviation.

(2) Measured at crossing points for differential clock input or at input threshold voltage  $V_{\text{TH}}$  for single-ended clock input.

(3) If input modulation is used; input modulation is allowed but not required.

(4) The amount of allowed spreading for any non-triangular modulation is determined by the induced downstream tracking skew, which cannot exceed the skew generated by the specified 0.6% triangular modulation. Typically, the amount of allowed non-triangular modulation is about 0.5%.

(5) See Figure 1 for the timing behavior of the serial interface.

## DEVICE CHARACTERISTICS

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER                        | TEST CONDITIONS   | MIN  | TYP   | MAX  | UNIT |      |   |
|----------------------------------|---|--|-------|------|------|------|---|
| <b>OVERALL PARAMETER</b>         |   |  |       |      |      |      |   |
| $I_{\text{DD}}$                  | Supply current (= $I_{\text{VDD}} + I_{\text{VDDP}} + I_{\text{VDDC}}$ )    | At 300 MHz and 2.625 V   |       | 70   | 85   | mA   |   |
|                                  |   | At 667 MHz and 2.625 V   |       | 90   | 115  |      |   |
| $V_{\text{PUC}}$                 | Supply voltage threshold for power-up control circuit                       | Over complete supply voltage range   |       | 1.1  | 1.8  | 2.2  | V |
| <b>DC DEVICE CHARACTERISTICS</b> |   |  |       |      |      |      |   |
| $V_{\text{OX}}$                  | Differential output crossing-point voltage <sup>(1)</sup>                   | Output load; see Figure 3.   |       | 0.9  | 1    | 1.1  | V |
| $V_{\text{COS}}$                 | Output voltage swing (p-p, single-ended) <sup>(2)</sup>                     | 0.3  | 0.325 | 0.35 |      |      | V |
| $V_{\text{OL,ABS}}$              | Absolute output low voltage <sup>(3)</sup>                                  | 0.85   |       |      |      |      | V |
| $V_{\text{ISET}}$                | Reference voltage for swing control current $I_{\text{REF}}$ <sup>(4)</sup> | $V_{\text{DD}} = 2.375 \text{ V to } 2.625 \text{ V}$ , $T = 0^\circ\text{C to } 70^\circ\text{C}$ |       | 0.98 | 1    | 1.02 | V |

(1)  $V_{\text{OX}}$  is measured on external divider as shown in Figure 3.

(2)  $V_{\text{COS}} = (\text{clock output high voltage} - \text{clock output low voltage})$ , at the measurement points shown in Figure 3, excluding overshoot and undershoot.

(3)  $V_{\text{OL,ABS}}$  is measured at the clock output of the package, instead of the measurement points of Figure 3.

(4)  $I_{\text{REF}}$  is equal to  $V_{\text{ISET}}/R_{\text{RC}}$ . Tolerance of  $R_{\text{RC}}$  must be  $\pm 1\%$  or smaller.

**DEVICE CHARACTERISTICS (continued)**

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER                        |   | TEST CONDITIONS  | MIN  | TYP  | MAX  | UNIT   |
|----------------------------------|---|--|------|------|------|--------|
| $I_{OL}/I_{REF}$                 | Ratio of output low current to reference current  |  | 6.8  | 7    | 7.2  |        |
| $I_{OL,ABS}$                     | Minimum current at $V_{OL,ABS}$ <sup>(5)</sup>  | $V_{OL,ABS} = 0.85\text{ V}$   | 45   |      |      | mA     |
| $V_{OL,SDA}$                     | SDA output low voltage  | $V_{DD} = 2.375\text{ V to } 2.625\text{ V}$ ,<br>$I_{OH} = 4\text{ mA}$   |      |      | 0.4  | V      |
| $I_{OL,SDA}$                     | SDA output low current  | $V_{DD} = 2.375\text{ V to } 2.625\text{ V}$ ,<br>$V_O = 0.8\text{ V}$   | 6    |      |      | mA     |
| $I_{OZ}$                         | Output 3-state current  | CLK0 to CLK4   |      |      | ±50  | μA     |
| $I_{IR}$                         | REFCLK input current  | $V_I = 0\text{ V or } V_{DD}$  |      |      | ±5   | μA     |
| $I_{IL}$                         | Logic input current   | $V_I = 0\text{ V or } V_{DD}$  |      |      | ±10  | μA     |
| <b>AC DEVICE CHARACTERISTICS</b> |   |  |      |      |      |        |
| $C_{IR}$                         | Input capacitance, REFCLK, REFCLKB <sup>(6)</sup>   |  |      | 2    | 7    | pF     |
| $C_{IL}$                         | Input capacitance logic pins <sup>(7)</sup>   |  |      | 2    | 10   | pF     |
| $t_{CYCLE}$                      | Clock cycle time <sup>(8)</sup>   | 300 MHz to 667 MHz, possible SSC is not taken into account   | 1.5  |      | 3.33 | ns     |
| $t_{jit(per)}$                   | Cycle-to-cycle jitter  of 1–6 clock cycles  | 10,000 cycles, 300 MHz to 635 MHz <sup>(9)</sup>   |      |      | 40   | ps     |
|                                  |   | 10,000 cycles, 636 MHz to 667 MHz <sup>(9)</sup>   |      |      | 30   |        |
| $L_1$                            | SSB phase noise at 1 MHz  | 300-MHz–667-MHz output <sup>(10)</sup>   |      | –115 | –97  | dBc/Hz |
| $L_{20}$                         | SSB phase noise at 20 MHz   | 300-MHz–667-MHz output <sup>(10)</sup>   |      | –150 | –128 | dBc/Hz |
| $\Delta t_{skew(o)}$             | Drift in $t_{skew(o)}$ <sup>(11)</sup>  | $V_{DD} = 2.375\text{ V to } 2.625\text{ V}$ ,<br>$T = 0\text{ to } 70^\circ\text{C}$                              |      |      | 15   | ps     |
| odc                              | Output duty cycle   |  | 45%  | 50%  | 55%  |        |
| $t_{ODC,ERR}$                    | Cycle-to-cycle  duty-cycle error  | 300 MHz to 635 MHz   |      |      | 40   | ps     |
|                                  |   | 636 MHz to 667 MHz   |      |      | 30   |        |
| $t_{ERR,SSC}$                    | PLL output phase error when tracking SSC  |  | –100 |      | 100  | ps     |
| $t_r/t_f$                        | Output rise and fall time   | $V_{OUT} = 20\%–80\%$  | 100  |      | 300  | ps     |
| $t_{cr}/t_{cf}$                  | Difference between output rise and fall times   | $V_{OUT} = 20\%–80\%$ , $f_{out} = 300\text{ MHz to } 667\text{ MHz}$  |      |      | 100  | ps     |
| $Z_{OUT}$                        | Output dynamic impedance <sup>(12)</sup>  | $V_{OL} = 0.9\text{ V}$  | 750  |      |      | Ω      |
| $t_L$                            | Power-up lock time  | Time from VDD, VDDP, VDDC being applied and settled until clock outputs are settled                                |      |      | 3    | ms     |
| $t_{L(\omega)}$                  | PLL lock time after (1) frequency change via serial interface (programming of SCL and SDA pins completed) or (2) EN and/or BYPASS changed state | Time from signals for selecting a mode of operation (1) or (2) applied and settled until clock outputs are settled |      |      | 3    | ms     |

(5) Minimum  $I_{OL,ABS}$  is measured at the clock output pins of the package, as shown in Figure 3.(6) Capacitance measured at frequency = 1 MHz, dc bias = 0.9 V, and  $V_{AC} < 100\text{ mV}$ (7) Capacitance measured at frequency = 1 MHz, dc bias = 0.9 V, and  $V_{AC} < 100\text{ mV}$ 

(8) Maximum and minimum output clock cycle times are based on nominal output frequency of 300 MHz and 667 MHz, respectively. For spread-spectrum-modulated differential or single-ended REFCLK, the output clock tracks the modulation of the input.

(9) Output short-term jitter specification is the absolute value of the worst-case deviation and is defined in the *Jitter* section.(10) Device must not exceed the upper limit of L(f) for 1-MHz to 100-MHz offset as shown in the *Phase Noise* section.(11)  $t_{skew}$  is the timing difference between any two of the four differential clocks and is measured at common-mode voltage.  $\Delta t_{skew}$  is the change in  $t_{skew}$  when the operating temperature and supply voltage change.(12)  $Z_{OUT}$  is defined at the output pins directly. The value is determined as the ac small-signal impedance at low frequencies (< 100 kHz) and when output is driving a high state.

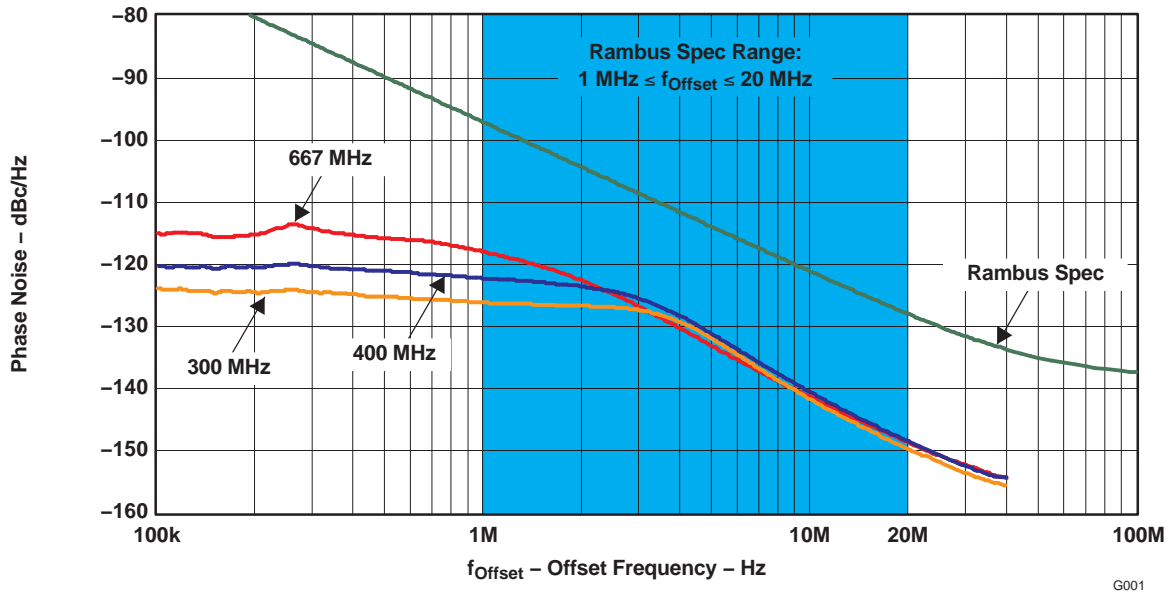
## PHASE NOISE

For the offset frequency range from 1 MHz to 100 MHz, phase noise of the CDCD5704 does not exceed the single-sideband phase noise (spectral purity) described by the following equation given by Rambus.

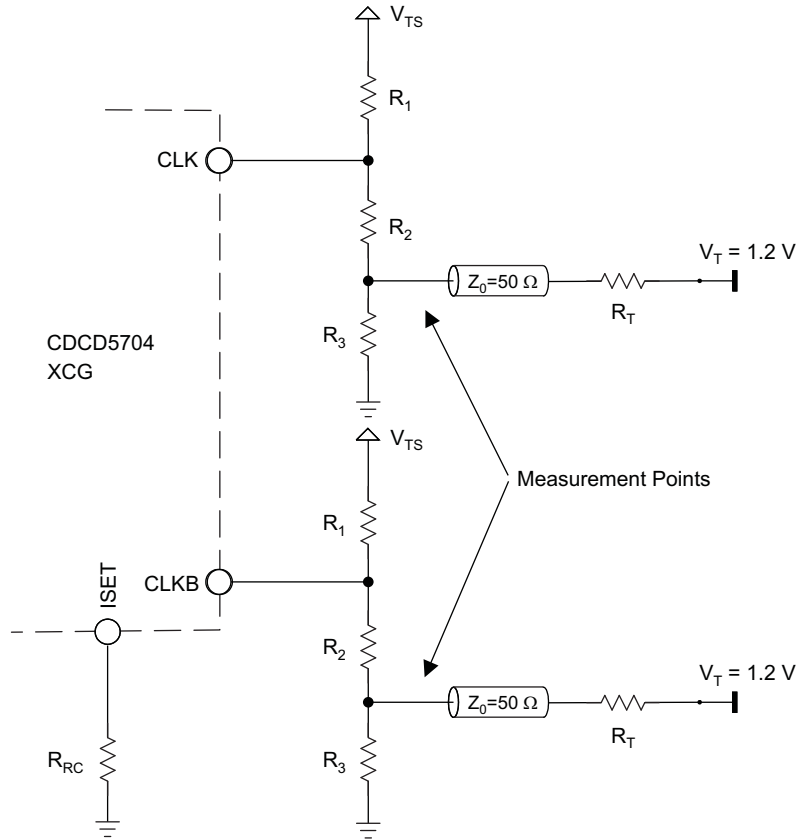
$$L(f) = 10 \log [1 + (50 \times 10^6 / f)^{2.4}] - 138 \text{ dBc/Hz}$$

Selected numerical values are given in the following table.

|                        |                     |      |      |      |                       |      |      |      |        |
|------------------------|---------------------|------|------|------|-----------------------|------|------|------|--------|
| f = offset frequency   | 1 (L <sub>1</sub> ) | 5    | 10   | 15   | 20 (L <sub>20</sub> ) | 40   | 80   | 100  | MHz    |
| L(f) = SSB phase noise | -97                 | -114 | -121 | -125 | -128                  | -134 | -137 | -138 | dBc/Hz |



**Figure 2. Phase Noise Plot**

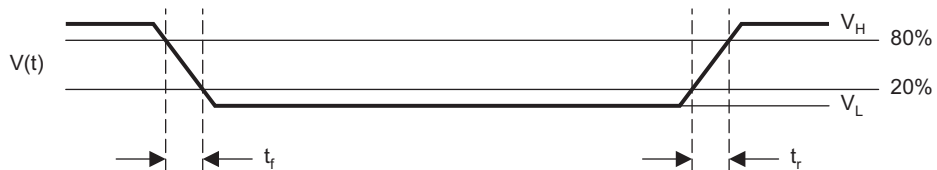


S0201-01

NOTE: In the power-up sequence, the rise time for the external voltage applied to the clock output pins ( $V_{TS}$ ) must be equal to or longer than the rise time for the supply voltage of the device ( $V_{DD}$ ,  $V_{DDP}$ ,  $V_{DDC}$ ).

| PARAMETER |                            | VALUE for 50-Ω LINE | VALUE for $I_{OL,ABS}$ | TOLERANCE | UNIT |
|-----------|----------------------------|---------------------|------------------------|-----------|------|
| $R_1$     | Termination resistor       | 39.2                | 34                     | ±1%       | Ω    |
| $R_2$     | Termination resistor       | 66.5                | 31.8                   | ±1%       | Ω    |
| $R_3$     | Termination resistor       | 93.1                | 48.7                   | ±1%       | Ω    |
| $R_T$     | Termination resistor       | 49.9                | 28                     | ±1%       | Ω    |
| $R_{RC}$  | Swing control resistor     | 200                 | 147                    | ±1%       | Ω    |
| $V_{TS}$  | Source termination voltage | 2.5                 | 2.5                    | ±5%       | V    |
| $V_T$     | Termination voltage        | 1.2                 | 1.2                    | ±5%       | V    |

Figure 3. Output Test Load



T0132-01

Figure 4. Input and Output Waveforms

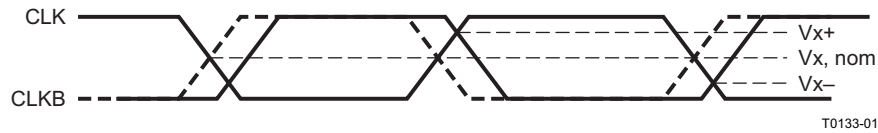


Figure 5. Crossing-Point Voltage

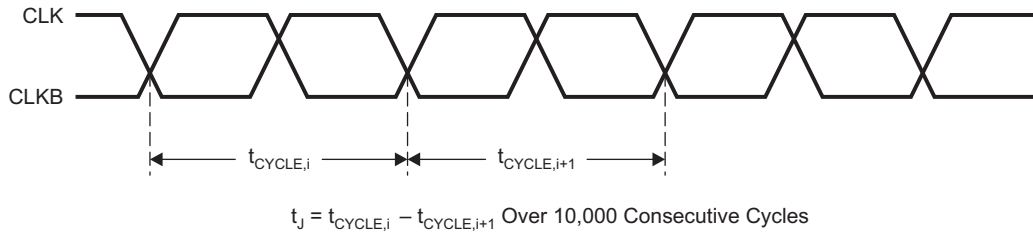


Figure 6. One-Period Cycle-to-Cycle Jitter

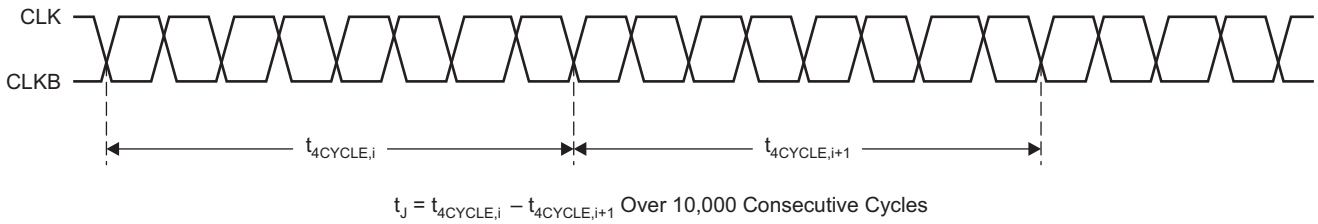


Figure 7. Four-Period Cycle-to-Cycle Jitter

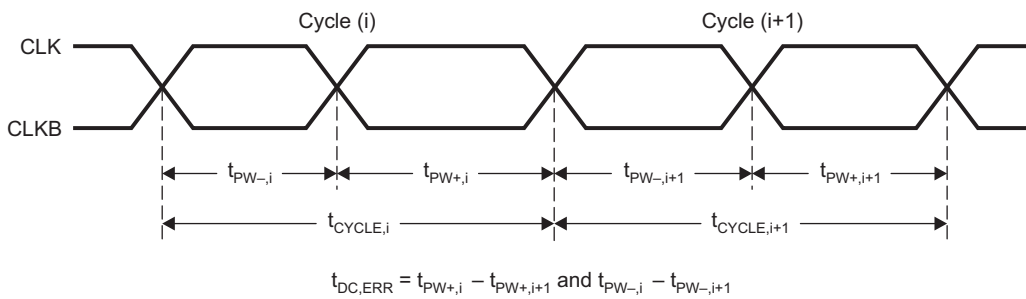
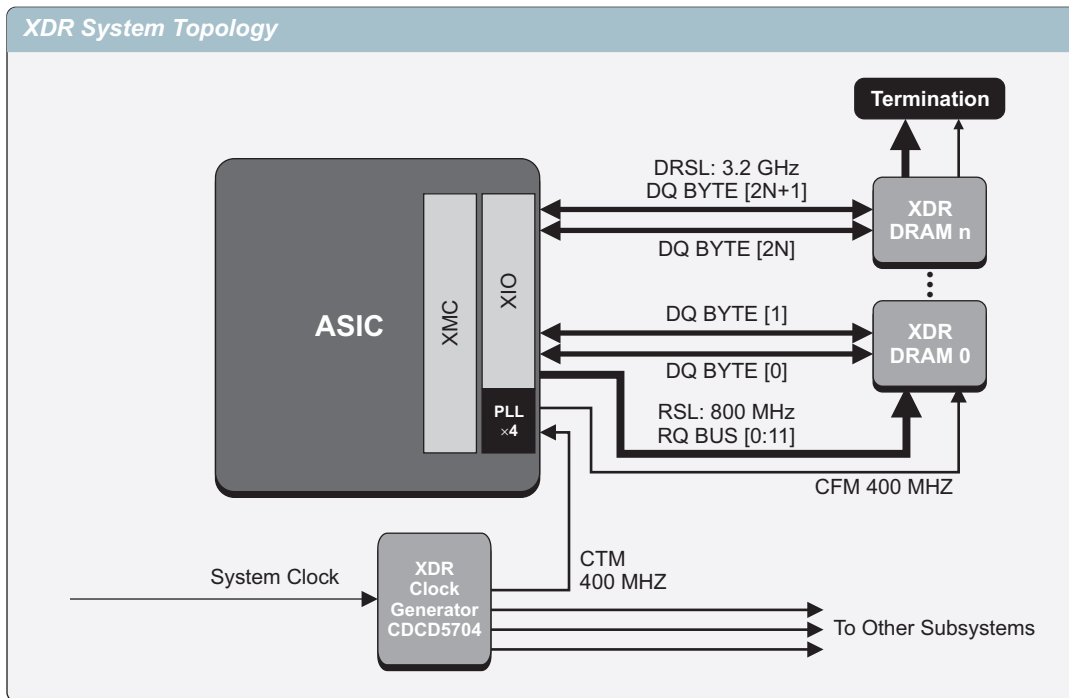


Figure 8. Cycle-to-Cycle Duty-Cycle Error

APPLICATION INFORMATION

XDR Memory Subsystem (Source: Rambus)



M0054-01

**PACKAGING INFORMATION**

| Orderable Device | Status<br>(1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan<br>(2) | Lead finish/<br>Ball material<br>(6) | MSL Peak Temp<br>(3) | Op Temp (°C) | Device Marking<br>(4/5) | Samples                 |
|------------------|---------------|--------------|-----------------|------|-------------|-----------------|--------------------------------------|----------------------|--------------|-------------------------|-------------------------|
| CDCD5704PW       | ACTIVE        | TSSOP        | PW              | 28   | 50          | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | 0 to 70      | CDCD5704.               | <a href="#">Samples</a> |
| CDCD5704PWG4     | ACTIVE        | TSSOP        | PW              | 28   | 50          | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | 0 to 70      | CDCD5704.               | <a href="#">Samples</a> |
| CDCD5704PWR      | ACTIVE        | TSSOP        | PW              | 28   | 2000        | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | 0 to 70      | CDCD5704.               | <a href="#">Samples</a> |
| CDCD5704PWRG4    | ACTIVE        | TSSOP        | PW              | 28   | 2000        | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | 0 to 70      | CDCD5704.               | <a href="#">Samples</a> |

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSELETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "-" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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**TAPE AND REEL INFORMATION**

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**


\*All dimensions are nominal

| Device      | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| CDCD5704PWR | TSSOP        | PW              | 28   | 2000 | 330.0              | 16.4               | 6.9     | 10.2    | 1.8     | 12.0    | 16.0   | Q1            |

**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

| Device      | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|-------------|--------------|-----------------|------|------|-------------|------------|-------------|
| CDCD5704PWR | TSSOP        | PW              | 28   | 2000 | 356.0       | 356.0      | 35.0        |

PW (R-PDSO-G28)

PLASTIC SMALL OUTLINE

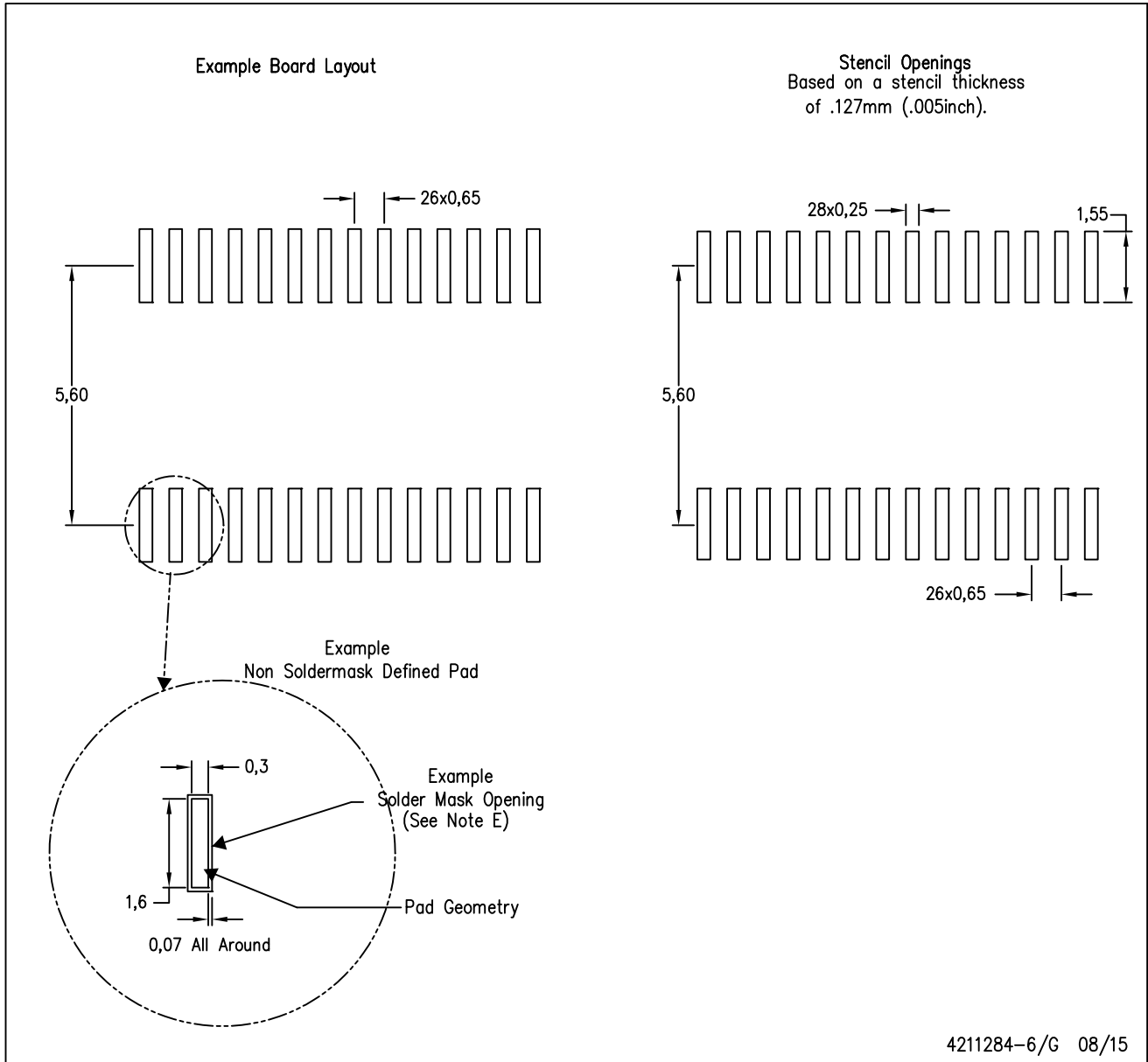


4040064-7/G 02/11

- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - B. This drawing is subject to change without notice.
  - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
  - D. Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
  - E. Falls within JEDEC MO-153

PW (R-PDSO-G28)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Publication IPC-7351 is recommended for alternate design.
  - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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